

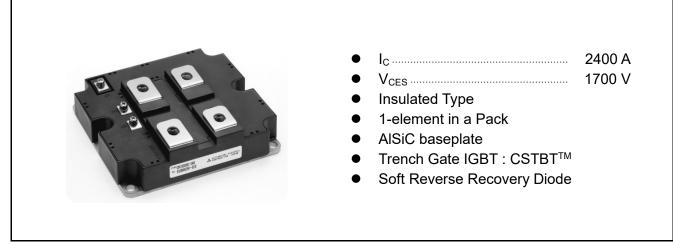
<High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM2400HC-34N

HIGH POWER SWITHCHING USE INSULATED TYPE

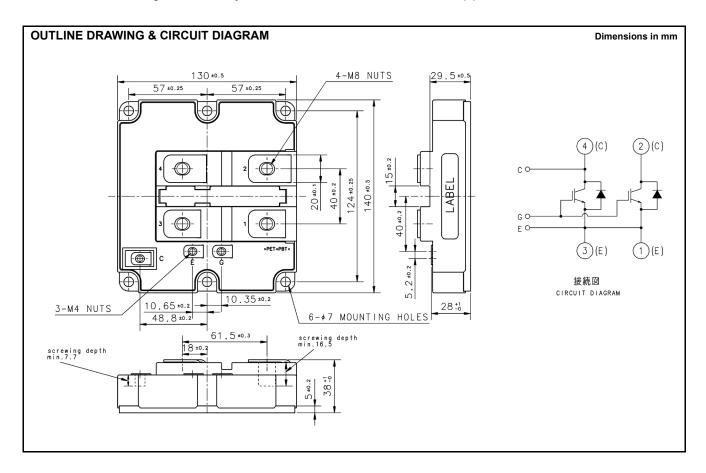
4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

CM2400HC-34N



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V, T_j = 25^{\circ}C$	1700	V
V_{GES}	Gate-emitter voltage	$V_{CE} = 0V, T_{j} = 25^{\circ}C$	± 20	V
lc	Callester sumert	DC, T _c = 75°C	2400	А
I _{CRM}	Collector current	Pulse (Note 1)	4800	А
l _E		DC	2400	Α
I _{ERM}	Emitter current (Note 2)	Pulse (Note 1)	4800	А
P _{tot}	Maximum power dissipation (Note 3)	T_c = 25°C, IGBT part	13100	W
V _{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	4000	V
Tj	Junction temperature		-40 ~ +150	°C
T _{jop}	Operating junction temperature		-40 ~ +125	°C
T _{stg}	Storage temperature		-40 ~ +125	°C
t _{psc}	Short circuit pulse width	V_{CC} = 1200V, $V_{CE} \le V_{CES}$, V_{GE} =15V, T_j =125°C	10	μs

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
Symbol	nem			Min	Тур	Max	Unit
1	Collector cutoff current		T _j = 25°C			8.0	mA
I _{CES}		$V_{CE} = V_{CES}, V_{GE} = 0V \qquad \qquad T_j = 125$			6.0	16.0	ma
V _{GE(th)}	Gate-emitter threshold voltage	V _{CE} = 10 V, I _C = 240 mA, T _j = 25°C		6.0	7.0	8.0	V
I _{GES}	Gate leakage current	$V_{GE} = V_{GES}$, $V_{CE} = 0V$, $T_j = 25^{\circ}C$		—	—	0.5	μA
C _{ies}	Input capacitance	V_{CE} = 10 V, V_{GE} = 0 V, f = 100 kHz T _j = 25°C			352		nF
C _{oes}	Output capacitance				19.2	—	nF
Cres	Reverse transfer capacitance				5.6		nF
Q_{G}	Total gate charge	V _{CC} = 850V, I _C = 2400A, V _{GE} = ±15V, T _j = 25°C			24.5		μC
	Collector-emitter saturation voltage	I _C = 2400 A ^(Note 4)	T _j = 25°C		2.15	2.80	
V _{CEsat}		V _{GE} = 15 V	T _i = 125°C		2.40		V
t _{d(on)}	Turn-on delay time	$ V_{CC} = 850 \text{ V}, I_C = 2400 \text{ A}, V_{GE} = \pm 15 \text{ V} \\ R_{G(on)} = 0.7 \Omega, T_j = 125^{\circ}\text{C}, L_s = 100 \text{ nH} \\ \text{Inductive load} $				1.50	μs
t _r	Turn-on rise time					0.70	μs
E _{on(10%)}	Turn-on switching energy (Note 5)				640		mJ
t _{d(off)}	Turn-off delay time	$ V_{CC} = 850 \text{ V}, I_C = 2400 \text{ A}, V_{GE} = \pm 15 \text{ V} \\ R_{G(off)} = 1.6 \ \Omega, T_j = 125^{\circ}\text{C}, L_s = 100 \text{ nH} \\ Inductive load $				3.00	μs
t _f	Turn-off fall time				_	0.60	μs
E _{off(10%)}	Turn-off switching energy (Note 5)				840		mJ
		I _E = 2400 A ^(Note 4)	T _i = 25°C		2.60	3.30	
V _{EC}	V _{EC} Emitter-collector voltage (Note 2)	$V_{GE} = 0 V$	T _i = 125°C	_	2.30		V
t _{rr}	Reverse recovery time (Note 2)	V _{CC} = 850 V, I _C = 2400 A, V _{GE} = ±15 V		_	_	1.50	μs
Q _{rr}	Reverse recovery charge (Note 2)	$R_{G(on)} = 0.7 \ \Omega$, $T_j = 125^{\circ}$ C, $L_s = 100 \text{ nH}$ Inductive load		_	620	_	μC
E _{rec(10%)}	Reverse recovery energy ^{(Note 2), (Note 5)}			_	380	_	mJ

THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Тур	Max	Unit
R _{th(j-c)Q}	Thermal resistance	Junction to Case, IGBT part			9.5	K/kW
R _{th(j-c)D}		Junction to Case, FWDi part			21.0	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, λ_{grease} = 1W/m k, $D_{(c-s)}$ = 100µm		8.0		K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Linit
		Conditions	Min	Тур	Max	Unit
Mt		M8 : Main terminals screw	7.0		20.0	N∙m
Ms	Mounting torque	M6 : Mounting screw	3.0		6.0	N∙m
Mt		M4 : Auxiliary terminals screw	1.0		3.0	N∙m
m	Mass			0.8		kg
CTI	Comparative tracking index		600			_
d _a	Clearance		19.5			mm
ds	Creepage distance		32.0			mm
L _{P CE}	Parasitic stray inductance	IGBT part	_	16	_	nH
R _{CC'+EE'}	Internal lead resistance	IGBT part , T _c = 25°C		0.14		mΩ

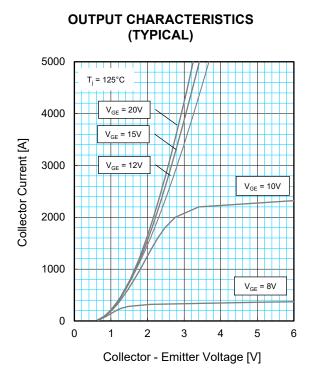
Note 1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

Note 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).

Note 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

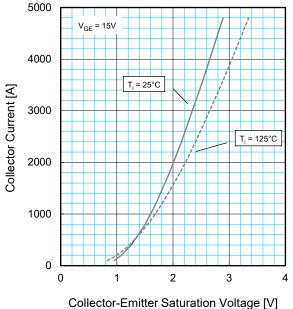
Note 5. $E_{on(10\%)}$ / $E_{off(10\%)}$ / $E_{rec(10\%)}$ are the integral of 0.1V_{CE} x 0.1I_C x dt.



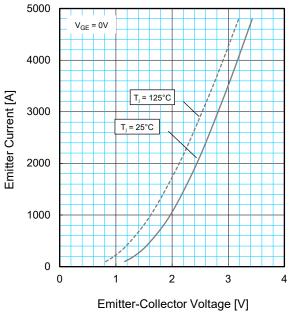
(TYPICAL) 5000 V_{CE} = 20V 4000 Collector Current [A] T_i = 125°C 3000 T_j = 25°C 2000 1000 0 5 10 15 0 Gate - Emitter Voltage [V]

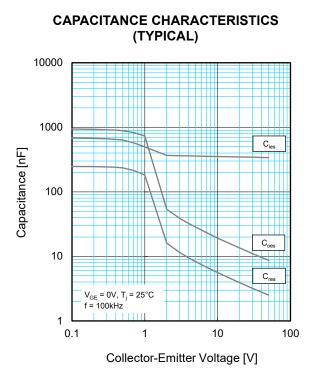
TRANSFER CHARACTERISTICS

COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

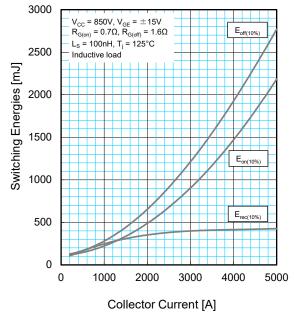




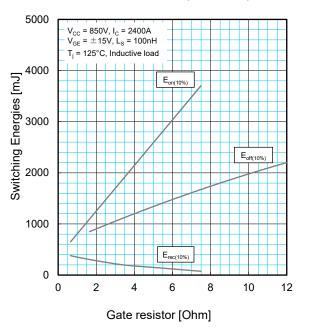
(TYPICAL) 20 V_{CE} = 850V, I_{C} = 2400A T_j = 25°C 15 Gate-Emitter Voltage [V] 10 5 0 -5 -10 -15 0 10 20 30 40 Gate Charge [µC]

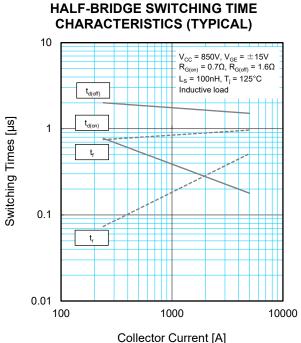
GATE CHARGE CHARACTERISTICS

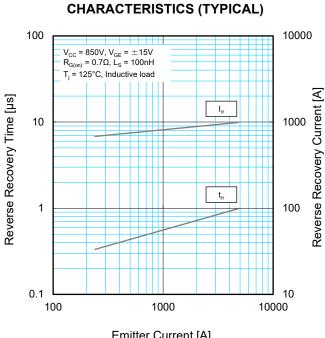
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



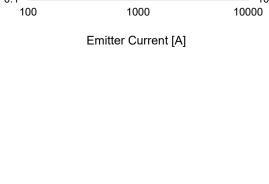
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)







FREE-WHEEL DIODE REVERSE RECOVERY



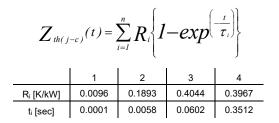
CHARACTERISTICS 1.2 $R_{th(j-c)Q} = 9.5K/kW$ $R_{th(j-c)D} = 21.0K/kW$. Tuun 1 0.8 0.6 0.4 0.2

0.1

Time [s]

1

TRANSIENT THERMAL IMPEDANCE

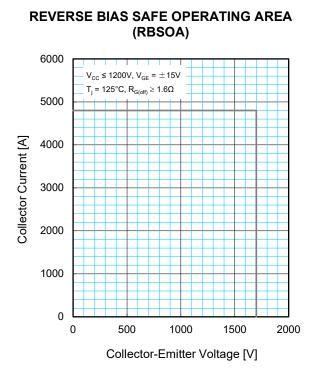


0 0.001

0.01

Normalized Transient Thermal impedance

10

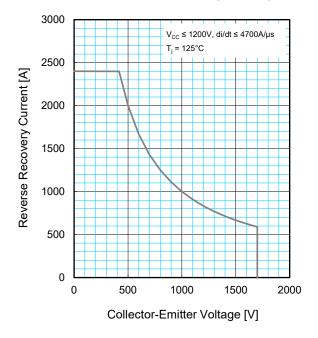


25000 $V_{CC} \le 1200V, V_{GE}$ = $\pm 15V$ $R_{G(on)} \geq 0.7\Omega, \ R_{G(off)} \geq 1.6\Omega$ $T_i = 125^{\circ}C, t_{psc} \le 10 \mu s$ 20000 Collector Current [A] 15000 10000 5000 0 0 500 1000 1500 2000 Collector-Emitter Voltage [V]

(SCSOA)

SHORT CIRCUIT SAFE OPERATING AREA

FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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